

Notice of References Cited

Application/Control No.

09/631,427

Applicant(s)/Patent Under

Reexamination

STEVEN P. LARKY

Examiner

Morella I Rosales-Hanner

Art Unit

2123

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U.S. PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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